

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10652327	ELZUR ET AL.
	Examiner Hoang, Hieu T	Art Unit 2152

SEARCHED

Class	Subclass	Date	Examiner
709	229, 230, 250	9/12/2007	HH

SEARCH NOTES

Search Notes	Date	Examiner
EAST	9/12/2007	HH
NPL (Google, IETF, IEEE)	9/12/2007	HH

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner